



KERSEMI

PD - 95600A

IRFR/U1205PbF

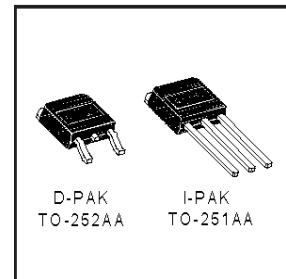
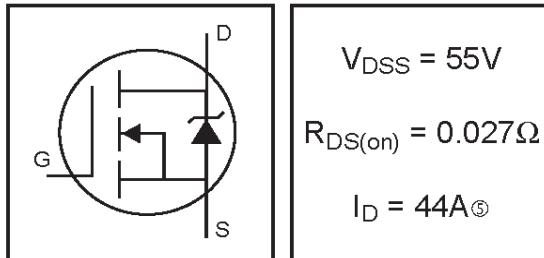
- Ultra Low On-Resistance
- Surface Mount (IRFR1205)
- Straight Lead (IRFU1205)
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The D-PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.

HEXFET® Power MOSFET



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	44 ^⑤	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	31 ^⑤	
I_{DM}	Pulsed Drain Current ^{①⑦}	160	
$P_D @ T_C = 25^\circ C$	Power Dissipation	107	W
	Linear Derating Factor	0.71	W/ ^o C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ^{②⑧}	210	mJ
I_{AR}	Avalanche Current ^{①⑦}	25	A
E_{AR}	Repetitive Avalanche Energy ^{①⑦}	11	mJ
dv/dt	Peak Diode Recovery dv/dt ^③	5.0	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

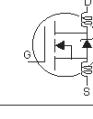
Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	1.4	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount) **	—	50	
$R_{\theta JA}$	Junction-to-Ambient	—	110	

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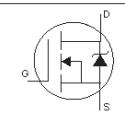
Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(BR)DSS/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.055	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.027		$V_{GS} = 10V, I_D = 26\text{A}$ ^④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	17	—	—	S	$V_{DS} = 25V, I_D = 25\text{A}$ ^⑦
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS} = 55V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
Q_g	Total Gate Charge	—	—	65		$I_D = 25\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	12	nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	27		$V_{GS} = 10V$, See Fig. 6 and 13 ^{④⑦}
$t_{d(on)}$	Turn-On Delay Time	—	7.3	—		
t_r	Rise Time	—	69	—		
$t_{d(off)}$	Turn-Off Delay Time	—	47	—		
t_f	Fall Time	—	60	—		
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact ^⑥
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	1300	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	410	—		$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	—	150	—		$f = 1.0\text{MHz}$, See Fig. 5 ^⑦



Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	44 ^⑤	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ^{①⑦}	—	—	160		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 22\text{A}, V_{GS} = 0V$ ^④
t_{rr}	Reverse Recovery Time	—	65	98	ns	$T_J = 25^\circ\text{C}, I_F = 25\text{A}$
Q_{rr}	Reverse Recovery Charge	—	160	240	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ^{④⑦}
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				



Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② $V_{DD} = 25V$, starting $T_J = 25^\circ\text{C}$, $L = 470\mu\text{H}$, $R_G = 25\Omega$, $I_{AS} = 25\text{A}$. (See Figure 12)
- ③ $I_{SD} \leq 25\text{A}$, $dI/dt \leq 320\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑤ Calculated continuous current based on maximum allowable junction temperature; Package limitation current = 20A
- ⑥ This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact
- ⑦ Uses IRFZ44N data and test conditions

** When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994



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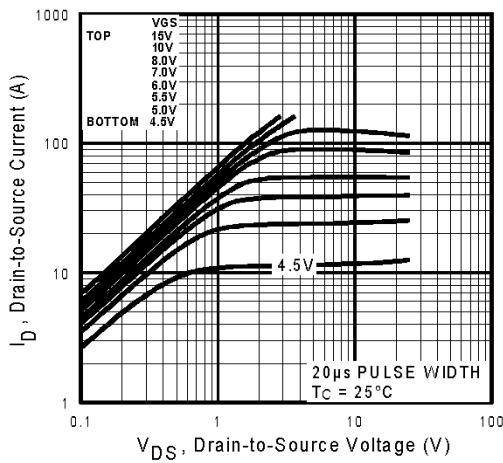


Fig 1. Typical Output Characteristics

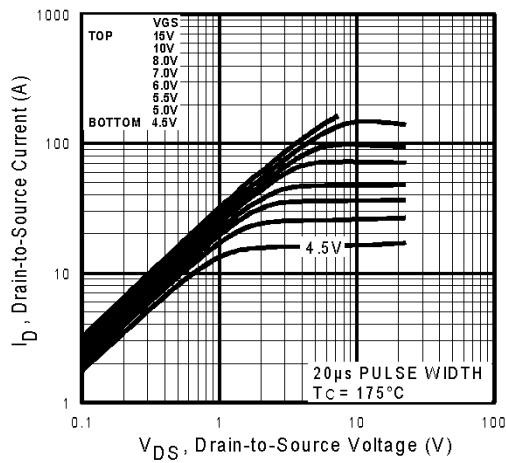


Fig 2. Typical Output Characteristics

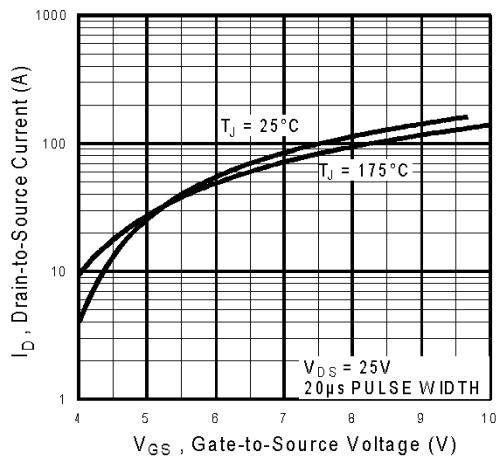


Fig 3. Typical Transfer Characteristics

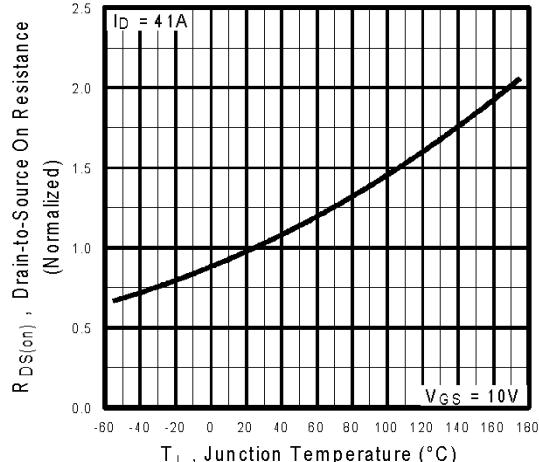


Fig 4. Normalized On-Resistance Vs. Temperature

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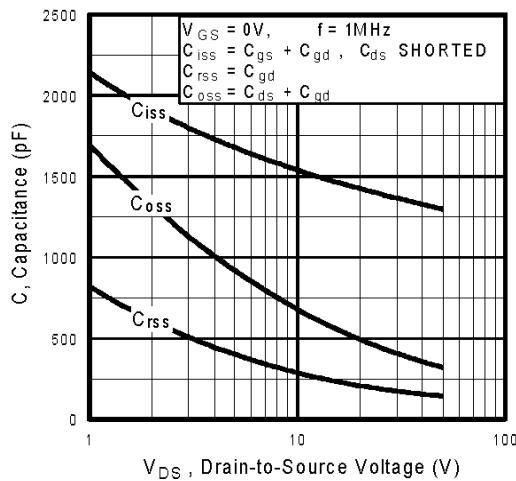


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

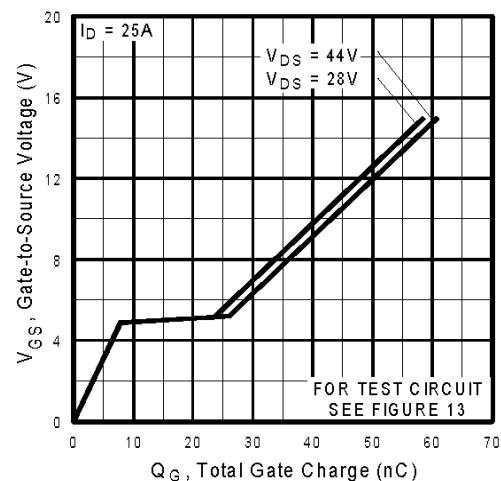


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

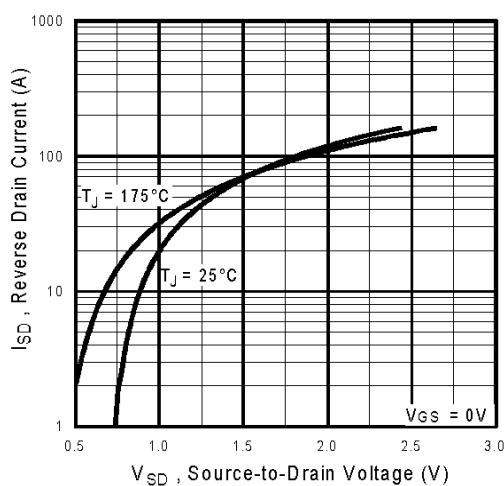


Fig 7. Typical Source-Drain Diode
Forward Voltage

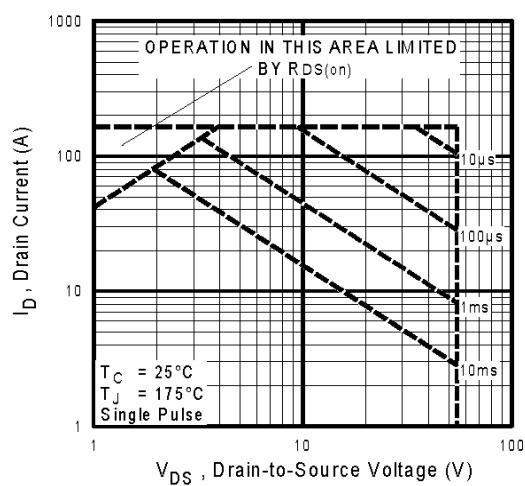


Fig 8. Maximum Safe Operating Area



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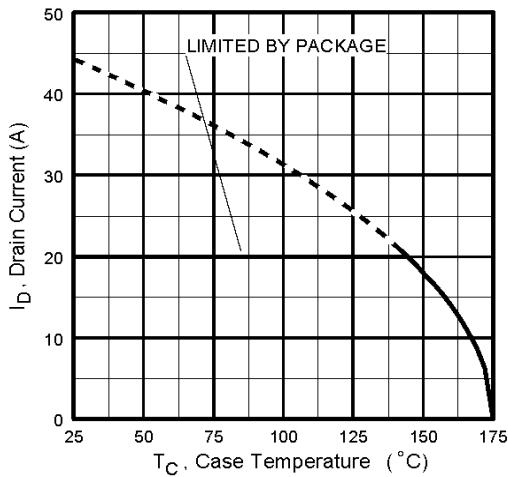


Fig 9. Maximum Drain Current Vs. Case Temperature

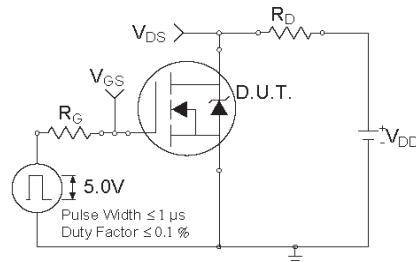


Fig 10a. Switching Time Test Circuit

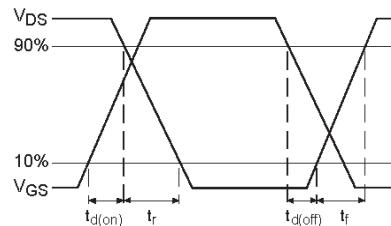


Fig 10b. Switching Time Waveforms

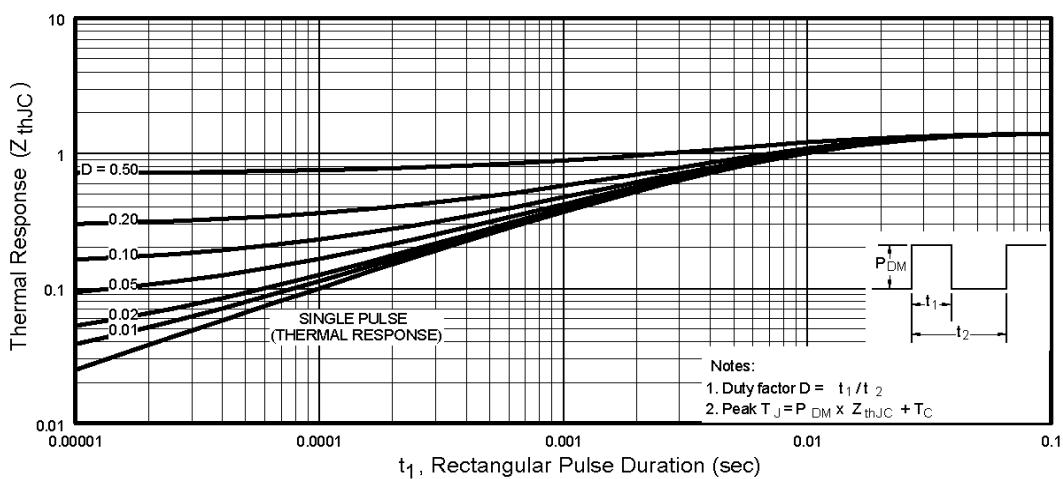


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



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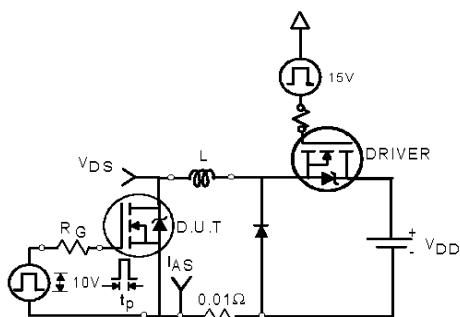


Fig 12a. Unclamped Inductive Test Circuit

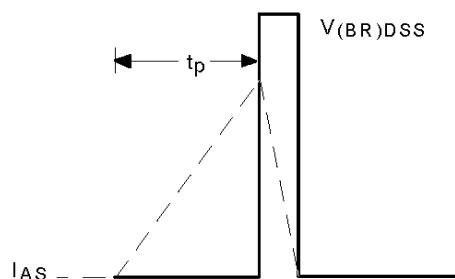


Fig 12b. Unclamped Inductive Waveforms

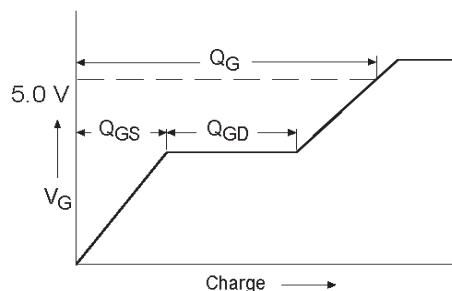


Fig 13a. Basic Gate Charge Waveform

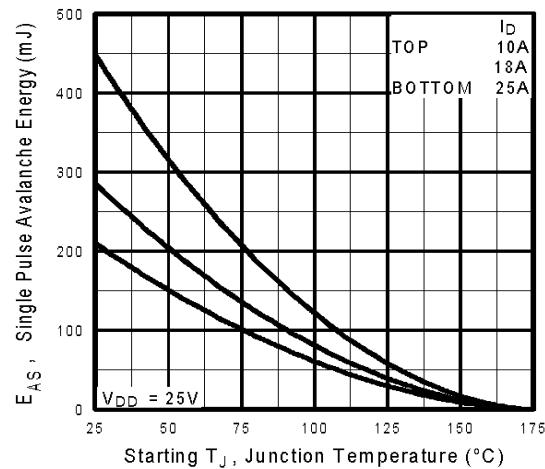


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

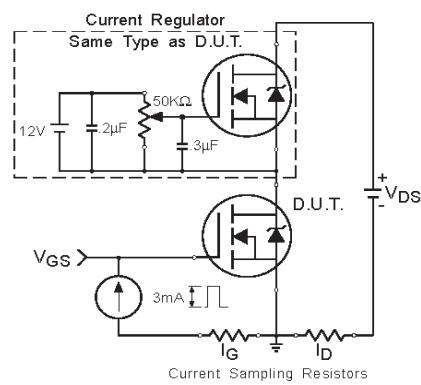


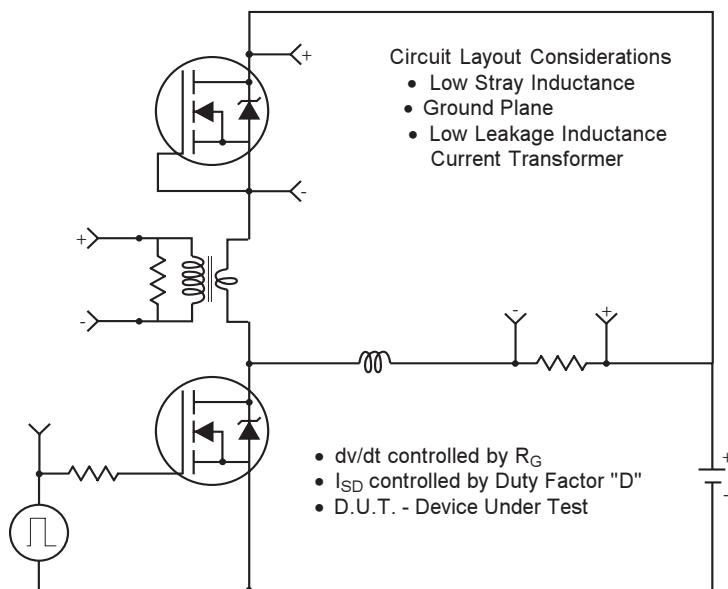
Fig 13b. Gate Charge Test Circuit



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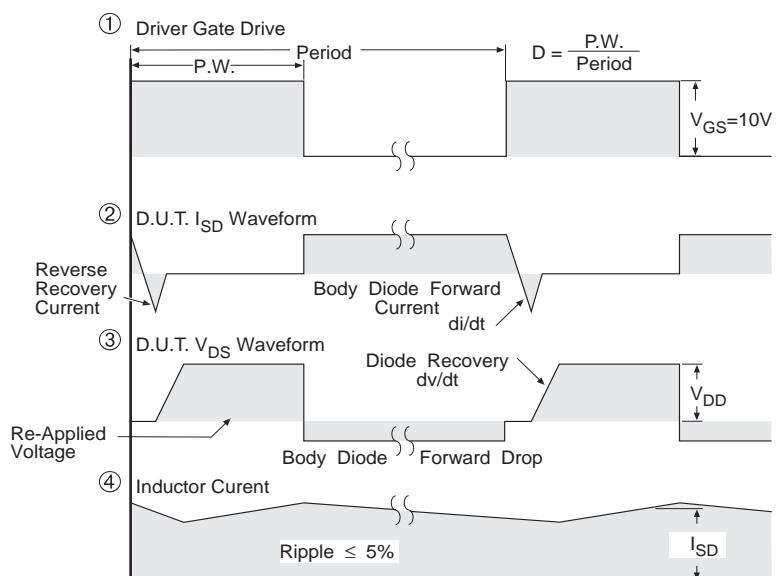
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Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity for P-Channel

** Use P-Channel Driver for P-Channel Measurements



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For N Channel HEXFETS

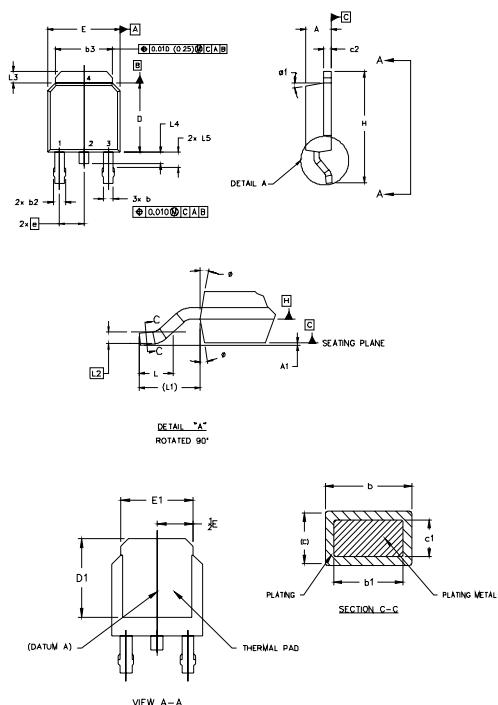


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IRFR/U1205PbF

D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	2.18	2.39	.086	.094	
A1			.013	.005	
b	0.64	0.69	.025	.035	5
b1	0.64	0.79	.025	.031	5
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	
c	0.46	0.61	.018	.024	5
c1	0.41	0.56	.016	.022	5
c2	.046	.089	.018	.035	5
d	5.97	6.22	.235	.245	6
d1	5.21	—	.205	—	4
e	6.35	6.73	.250	.285	6
e1	4.32	—	.170	—	4
e	2.29	—	.090	.095	
H	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	REF.	—	.108 REF.	
L2	0.051	BSC	—	.020 BSC	
L3	0.89	1.27	.035	.050	
L4		1.02	—	.040	
L5	1.14	1.52	.045	.060	
Ø	0°	10°	0°	10°	
Ø1	0°	15°	0°	15°	

LEAD ASSIGNMENTS

1.	GATE
2.	DRAIN
3.	SOURCE
4.	DRAIN

IGBTs, CoPACK

1.	GATE
2.	COLLECTOR
3.	EMITTER
4.	COLLECTOR

3

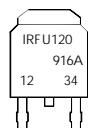
D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120
WTH ASSEMBLY
LOT CODE 1234
ASSEMBLED ON WW 16, 1999
IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line position
indicates "Lead-Free"

INTERNATIONAL
RECTIFIER
LOGO

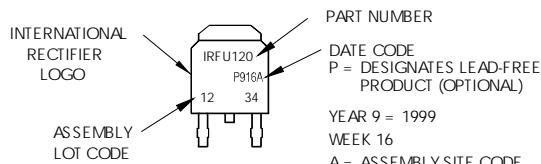
ASSEMBLY
LOT CODE



PART NUMBER

DATE CODE
YEAR 9 = 1999
WEEK 16
LINE A

OR



PART NUMBER
DATE CODE
P = DESIGNATES LEAD-FREE
PRODUCT (OPTIONAL)

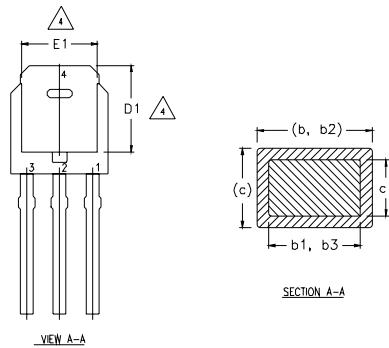
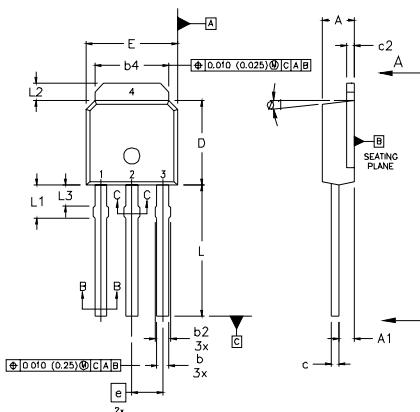
YEAR 9 = 1999
WEEK 16
A = ASSEMBLY SITE CODE



KERSEMI

IRFU1205PbF

I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches))



VIEW A-A

NOTES:

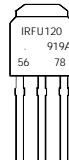
- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
- 5 LEAD DIMENSION UNCONTROLLED IN L3.
- 6 DIMENSION b1, b3 APPLY TO BASE METAL ONLY.
- 7 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- 8 CONTROLLING DIMENSION : INCHES.

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	2.18	2.39	0.086	.094		
A1	0.89	1.14	0.035	0.045		
b	0.64	0.89	0.025	0.035		
b1	0.64	0.79	0.025	0.031	4	
b2	0.76	1.14	0.030	0.045		
b3	0.76	1.04	0.030	0.041		
b4	5.00	5.46	0.195	0.215	4	
c	0.46	0.61	0.018	0.024		
c1	0.41	0.56	0.016	0.022		
c2	.046	0.86	0.018	0.035		
D	5.97	6.22	0.235	0.245	3, 4	
D1	5.21	-	0.205	-	4	
E	6.35	6.73	0.250	0.265	3, 4	
E1	4.32	-	0.170	-	4	
e	2.29		0.090 BSC			
L	8.89	9.60	0.350	0.380		
L1	1.91	2.29	0.075	0.090		
L2	0.89	1.27	0.035	0.050	4	
L3	1.14	1.52	0.045	0.060	5	
ø1	0'	15'	0'	15'		



PART NUMBER

DATE CODE
YEAR 9 = 1999
WEEK 19
LINE A

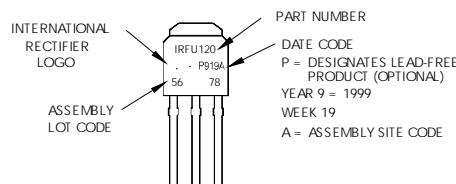
EXAMPLE: THIS IS AN IRFU120
WITH ASSEMBLY
LOT CODE 5678
ASSEMBLED ON WW 19, 1999
IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line
position indicates "Lead-Free"

INTERNATIONAL
RECTIFIER
LOGO

ASSEMBLY
LOT CODE

OR



PART NUMBER

DATE CODE
P = DESIGNATES LEAD-FREE
PRODUCT (OPTIONAL)
YEAR 9 = 1999
WEEK 19
A = ASSEMBLY SITE CODE

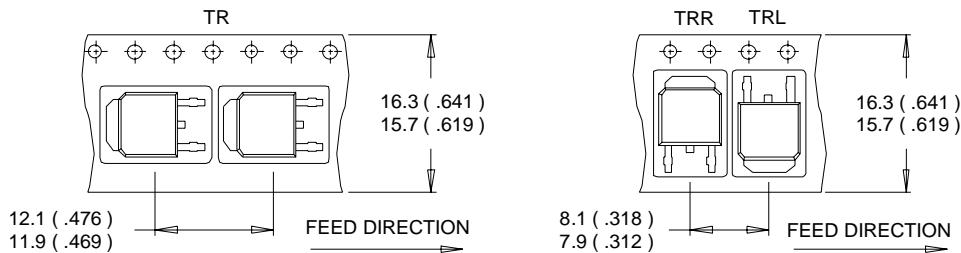


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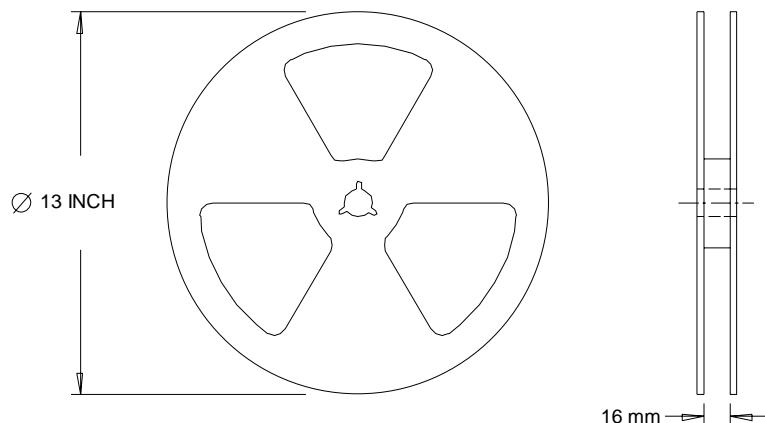
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.